

Cairnhill Metrology Sdn Bhd (178240W)

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Emerging Trends and Innovative Technologies in Optical 3D Metrology

We are thrilled to invite you to our upcoming seminar highlighting the latest advancements in Optical 3D Metrology. We will focus on the current academic and research studies, and demonstrate the applications of the hi-speed hi-resolution Focus Variation Technology by Bruker Alicona. Don't miss the chance to see our technology in action!

Date	Tuesday, 11 June 2024	
Time	09:30 AM – 04:30 PM. (Registration begins at 09:00 AM)	
Venue	18 Jalan Serendah 26/41, Sekitar 26, Seksyen 26 40400 Shah Alam, Selangor Darul Ehsan, Malaysia <u>Location Map</u>	
Our speakers	Dominik Urlep Regional Sales Manager, APAC Bruker Alicona	Prof. Dr. Azman Jalar Principal Research Fellow & Microelectronics Semiconductor Packaging Group Leader National University of Malaysia (UKM)
Topics	 I. Surface Dynamic: A Two-Decade Perspective on Alicona 3D Metrology in Malaysian Research II. Exploring the Versatility of Optical 3D Metrology Across Industries: A Deep Dive into Unique Measurement Strategies 	
Why Should You Attend		

- Discover emerging applications and potential research in the field relevant to 3D measurement technologies.
- Understand the principles and applications of Optical 3D Metrology for high-precision 3D measurement data acquisition.
- Gain real-world insights showcasing the benefits of Optical 3D Metrology in various industries and applications.

Free Registration. To Reserve: RSVP here or send us an email at sales@cairnhill.com. First come, first served.

Lunch and refreshments provided

You may also approach our speakers for a one-to-one private discussion